Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/645,815	BOUTAGHOU ET AL.	
Examiner	**Art Unit**	
Tianjie Chen	2627	

SEARCHED			
Class	Subclass	Date	Examiner
3670	245.9	4/9/2007	TJ

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
360	**245.9**	4/9/2007	**TJ**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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